

<b>Notice of References Cited</b>	Application/Control No. 10/790,077	Applicant(s)/Patent Under Reexamination CHEN, SHYAN-WEI	
	Examiner Rodney M. Lindsey	Art Unit 3765	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-1,449,183	03-1923	JOHNSTONE JAMES E	2/9
	B	US-1,488,812	04-1924	THOMAS GOODMAN	2/9
	C	US-2,028,462	01-1936	ROBERT MALCOM	2/9
	D	US-4,692,002	09-1987	Meistrell, Robert W.	351/156
	E	US-4,910,806	03-1990	Baker et al.	2/452
	F	US-5,046,200	09-1991	Feder, Irving	2/452
	G	US-5,184,354	02-1993	Alfaro et al.	2/425
	H	US-5,267,353	12-1993	Milligan, Norman O.	2/9
	I	US-5,542,128	08-1996	Lomas, Christiane	2/173
	J	US-5,662,101	09-1997	Ogden et al.	128/205.25
	K	US-6,012,164	01-2000	Deal, III, James F.	2/9
	L	US-6,038,706	03-2000	Seiler, Douglas A.	2/426
	M	US-2004/0025882	02-2004	Madaus et al.	128/206.27

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08024390 A	01-1996	Japan	ASICS	A63B 71/10
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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